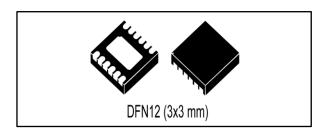


## IO-Link communication transceiver device IC

Datasheet - production data



#### **Features**

- Supply voltage from 7 V to 36 V
- 5 V and 3.3 V compatible I/Os
- 5 V or 3.3 V, 10 mA selectable linear regulator
- 0.3 A output current intervention threshold
- Fully protected
  - Reverse polarity
  - Overload with cut-off function
  - Overtemperature
  - Undervoltage and overvoltage
  - GND and V<sub>CC</sub> open wire
- -40 to +125 °C operating ambient temperature
- Selectable output stages: high-side, lowside, push-pull
- Suitable to drive L, C and R loads
- 30 μF output load drive capability
- Switching capability of inductors up to 500 mJ
- Wake-up detection supported
- Fast demagnetization of inductive loads
- COM1, COM2 and COM3 mode supported
- Designed to meet:
  - Burst IEC 61000-4-4

- ESD IEC 61000-4-2
- Surge EN60947-5-2
- Miniaturized VFDFPN 12L (3x3x0.90 mm) package

### **Applications**

- Industrial sensors
- Factory automation
- Process control

### **Description**

The L6362A is an IO-Link and SIO mode transceiver device compliant to PHY2 (3-wire connection) supporting COM1 (4.8 kbaud), COM2 (38.4 kbaud) and COM3 (230.4 kbaud) modes. The output stage can be configured as high-side, low-side or push-pull and it can drive resistive, capacitive and inductive loads. It can be connected to a sensor chip with the industrial 24 V environment. The industrial environment could be a PLC, an IO-Link master, a relay or a valve. The L6362A is protected against reverse polarity, among VCC, GND, OUTH, OUTL and I/Q pins. Furthermore, the IC is protected against output short-circuit, overvoltage and impulse voltage withstand (±1 kV pulse amplitude, 1.2/50 µs pulse duration, 500  $\Omega$  source impedance).

**Table 1: Device summary** 

Order code	Package	Packing
L6362ATR	VFDFPN 12L (3x3x0.90 mm)	Tape and reel

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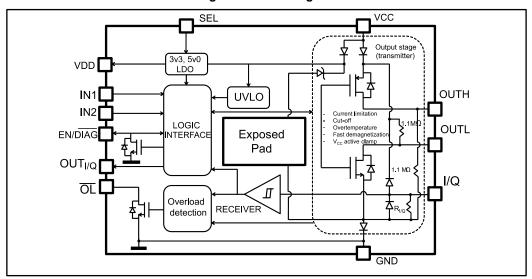
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Block diagram L6362A

# 1 Block diagram

Figure 1: Block diagram



L6362A Pin description

# 2 Pin description

Figure 2: Pin connection (top through view)

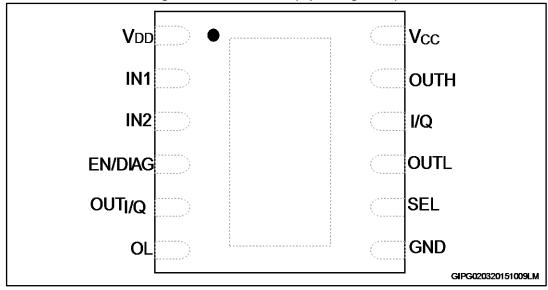


Table 2: Pin description

Number	Name	Function	Туре
1	$V_{DD}$	Linear regulator output voltage	Output
2	IN1	Digital input	Input
3	IN2	Digital input	Input
4	EN/DIAG	Output enable/fault diagnostic	Input/output open drain
5	OUT <sub>I/Q</sub>	I/Q channel logic output	Output
6	OL	Overload (diagnostic)	Output (open drain)
7	GND	IC ground	Supply
8	SEL	Linear regulator output voltage selection	Input
9	OUTL	LS channel output	Output
10	I/Q	I/Q receiver line	Input
11	OUTH	HS channel output	Output
12	V <sub>CC</sub>	IC supply voltage	Supply
13	Exposed pad	Not connected	



In order to guarantee all features and protections, the exposed pad cannot be electrically connected to any other net. To improve the thermal performance, it can be connected to a floating copper area.

Pin description L6362A

#### 2.1 IN1, IN2

These pins control the output stage on OUTH and OUTL pins, see *Table 14:* "Output stage truth table". When used in push-pull configuration (OUTH and OUTL wired together), the IC must be driven by the IN2 pin, to allow the dead time function to protect the output stage. The IN1 pin can be wired to GND or  $V_{DD}$  depending on the desired polarity. In order to avoid IC overstress, in push-pull configuration, IN1 pin has to be hardwired to  $V_{DD}$  or GND. IN1 could be also actively controlled, but must be switched only while EN/DIAG pin is at a low logic level. When used in high-side (OUTL left unconnected) or low-side (OUTH left unconnected) configurations, the IC should be driven by the IN1 pin, in order to avoid the unnecessary delay, which is introduced by the dead time function. The pin IN2 can be wired to GND or  $V_{DD}$  depending on the desired polarity, or can be actively controlled (for example by a microcontroller).

### 2.2 EN/DIAG

This pin controls the output stage on pins OUTH and OUTL. When EN/DIAG is at a low logic level (GND), the output stage is disabled. The EN/DIAG pin is also internally wired to an open drain transistor, used for diagnostic purposes and must be driven through a series resistor. The open drain transistor turns on in case of faults. EN/DIAG pin has an internal weak pull-down resistor. If the OUTH and OUTL pins are wired together the IC can be still used in HS or LS mode (with slow demagnetization) by applying a fixed high or low level voltage to IN1 pin, using the IN2 pin to set the polarity and the EN/DIAG pin to control the power stage.

#### 2.3 OUT I/Q

This pin reports the status of the receiver line (I/Q). It swings from GND to  $V_{DD}$  and should generally be connected to a microcontroller input.  $OUT_{I/Q}$  relation to I/Q is shown in *Table 14:* "Output stage truth table".

#### 2.4 SEL

This pin cannot be left floating and it allows the linear regulator output voltage to be configured at 3.3 V or 5 V.

SEL	V <sub>DD</sub> supplied voltage	
GND	3.3 V	
V <sub>DD</sub>	5 V	

Table 3: Linear regulator voltage configuration

### 2.5 VDD

This is the output of the integrated linear voltage regulator and the supply voltage of the I/O interface. It can supply a small current ( $I_{\text{scr}}$ ) to a microcontroller or external circuitry. The integrated liner regulator could supply the whole system, provided that the amount of required current is within IC limits, or the system can be supplied by an external regulator and the regulator integrated in the IC supplies the integrated logic only.

#### 2.6 GND

IC ground.

L6362A Pin description

### 2.7 OL

This pin has an open drain structure and is active low. The open drain is active in case of overload (current limitation). It can be used by the host microcontroller to detect an IO-Link wake-up request event.

### 2.8 VCC

IC supply voltage.

### 2.9 **OUTH**

This pin is the output of the high-side power transistor.

#### 2.10 OUTL

This pin is the output of the low-side power transistor.

### 2.11 I/Q

Input pin of the integrated receiver. The level of the signal on I/Q pin is transferred to the OUTI/Q pin, according to the receiver thresholds defined in *Table 8: "Output stage"*, and truth table see *Table 14: "Output stage truth table"*. In IO-Link mode, OUTH and OUTL outputs have to be connected to the load. I/Q pin has to be connected to the load as well, through a 22 k $\Omega$  resistor. If it is not used, this pin can remain floating; it has to be connected to GND to improve EMC robustness.

# 3 Absolute maximum ratings

Table 4: Absolute maximum ratings

Symbol	Parameter	Value	Unit
V	Supply voltage (steady-state)	-36 to +36	V
Vcc	Supply voltage transient <sup>(1)</sup>	Internally limited	V
V	HS or LS output channel voltage (steady-state)	-36 to +36	
Vouth Voutl	HS or LS output channel voltage (transient) (1)	Internally limited	V
Viva	I/Q channel voltage (steady-state)	-36 to +36	V
V <sub>I/Q</sub>	I/Q channel voltage (transient) (1)	Internally limited	
V <sub>IN1, IN2</sub>	IN voltage	-0.3 to V <sub>DD</sub> +0.3	V
V <sub>EN</sub>	EN/DIAG voltage	-0.3 to V <sub>DD</sub> +0.3	٧
V <sub>SEL</sub>	SEL voltage	-0.3 to V <sub>DD</sub> +0.3	V
Vol	OL voltage	-0.3 to V <sub>DD</sub> +0.3	V
Iouth,outl	Output stage current (continuous) (1)	Internally limited	Α
Icc	Supply current	2 <sup>(2)</sup>	Α
I <sub>OUT_I/Q</sub>	OUT <sub>I/Q</sub> current	-10/+10	mA
loL	OL	-10/+10	~ ^
I <sub>EN</sub>	EN/DIAG current	-10/+10	mA
P <sub>D</sub>	Power dissipation	Internally limited	W
TJ	Junction temperature	-40 to 150	Ĵ
T <sub>Stor</sub>	Storage temperature range	-55 to 150	C

#### Notes:

<sup>&</sup>lt;sup>(2)</sup>Peak value during fast transient test only.



Absolute maximum ratings are those values beyond which damage to the device may occur. Functional operation under these conditions is not implied. All voltages are referred to GND.

Table 5: Thermal data

Symbol	Symbol Parameter		Unit
R <sub>th(JC)</sub>	Thermal resistance junction-case	2.5	
	Thermal resistance junction-ambient. (FR4, Cu thick. 35 µm, 2 layers, the exposed pad is not soldered to total exposed area = 5 mm²)	200	°C/W
R <sub>th(JA)</sub>	Thermal resistance junction-ambient. (FR4, Cu thick. 35 µm, 2 layers, the exposed pad is soldered to total exposed area = 5 mm²)	100	

 $<sup>^{(1)}</sup>$ During fast transients according to IEC61000-4-5 (±1 kV, RC coupling R=500  $\Omega$ , C=18  $\mu$ F).

Symbol	Parameter	Value	Unit
	Thermal resistance junction-ambient. (FR4, Cu thick. 35 µm, 2 layers, the exposed pad has to be soldered to total exposed area = 100 mm² with vias)	50	

# 4 Recommended operating conditions

**Table 6: Recommended operating conditions** 

Symbol	Parameter	Min.	Тур.	Max.	Unit
Vcc	Supply voltage	7		36	V
Cvcc	Capacity on Vcc pin	1			μF
C <sub>VDD</sub>	Capacity on V <sub>DD</sub> pin	47		68	nF



 $C_{VDD}$  higher than recommend values is allowed but external protection nets on  $V_{DD}$  could be necessary for high  $V_{CC}$  slew rate (>15 V/µs).

# 5 Electrical characteristics

 $(7 \text{ V} < \text{V}_{CC} < 36 \text{ V}; -40 ^{\circ}\text{C} < T_{J} < 125 ^{\circ}\text{C}, \text{ unless otherwise specified})$ 

Table 7: Supply

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
Vuvon	Undervoltage on threshold		5.5		6.5	>
Vuvoff	Undervoltage off threshold		5.1		5.9	>
$V_{\text{UVH}}$	Undervoltage hysteresis		300			mV
Icc		Vcc = 24 V, no-load on output stage and V <sub>DD</sub> , EN/DIAG=1	1.2		2.3	
	Supply current	Vcc = 36 V, no-load on output stage and V <sub>DD</sub> , EN/DIAG=1	1.4		2.5	mA
		V <sub>CC</sub> = 5 V, no-load on output stage and V <sub>DD</sub> , EN/DIAG=1			0.8	
		Vcc = 24 V, no-load on output stage and V <sub>DD</sub> , EN/DIAG=0			2	
SR	Maximum slew rate of Vcc increase from off condition to avoid current pulse on output stage (lout < 10 mA)	OUTH = GND or OUTL = Vcc, EN=GND Vcc = 36 V		1.5		V/µs

Table 8: Output stage

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
	High-side on-	I <sub>OUT</sub> = 0.1 A @ T <sub>J</sub> = 25 °C		1		
6	state resistance	I <sub>OUT</sub> = 0.1 A @ T <sub>J</sub> = 125 °C			1.6	
R <sub>DS(on)</sub>	Low-side on-	lо∪т = 0.1 A @ T <sub>J</sub> = 25 °C		0.8		Ω V
	resistance	I <sub>ОUТ</sub> = 0.1 A @ T <sub>J</sub> = 125 °C			1.4	
Volhs	OUTH output voltage	Vcc = 24 V; open load; EN/DIAG=0			3	<b>V</b>
V <sub>OLLS</sub>	OUTL output voltage	V <sub>CC</sub> = 24 V; open load; EN/DIAG = 0	V <sub>CC</sub> -3			٧
Lau	Output leakage current HS	Output leakage current (HS) IN1 = GND, IN2 = GND, EN = V <sub>DD</sub> and OUTH = GND		1	10	μΑ
current I S		Output leakage current (LS) IN1 = V <sub>DD</sub> , IN2 = GND, EN = V <sub>DD</sub> and OUTL = V <sub>CC</sub>		0.7	10	μΑ
Іорр	Current from OUT pin in PP	Output current (PP) EN = GND and OUT = Vcc or OUT = GND			70	μΑ

Table 9: I/Q receiver

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit			
.,	I/O com an exalta ma themach ald	8 V < V <sub>CC</sub> < 18 V	61.1		69.4	%Vcc			
V <sub>I/QTHLH</sub>	I/Q upper voltage threshold	V <sub>CC</sub> ≥ 18 V	11	11.75	12.5	٧			
.,,	I/O laviar valtara threah ald	8 V < Vcc < 18 V	47.2		61.1	%Vcc			
V <sub>I/QTHHL</sub>	I/Q lower voltage threshold	V <sub>CC</sub> ≥ 18 V	8.5	9.75	11	V			
$V_{QHY}$	I/Q hysteresis voltage	V <sub>CC</sub> ≥ 18 V	0.8	2		V			
R <sub>I/Q</sub>	Weak pull-down on I/Q pin		250		550	kΩ			
t <sub>dbq</sub>	I/Q debounce time		30	50	110	ns			

Table 10: Timing VCC = 24 V

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
DT <sub>HS-LS</sub>	Dead time between HS switch-off and LS switch-on (push-pull configuration)	IN2 commutations only LOAD <sub>H</sub> = 120 Ω between OUT		110		
DT <sub>LS-HS</sub>	Dead time between LS switch-off and HS switch-on (push-pull configuration)	and GND; LOAD $_L$ = 120 $\Omega$ between OUT and $V_{CC}$		140		ns
t <sub>pI/Q</sub>	I/Q to OUT <sub>I/Q</sub> propagation delay time				200	
		EN/DIAG = $V_{DD}$ , IN1 commutations in HS or LS configurations only. R-L load (120 $\Omega$ , 10 $\mu$ H) to GND in HS; to $V_{CC}$ in LS			370	ns
t <sub>Р</sub> ОИТ	INx (or EN/DIAG) to OUTH or OUTL propagation delay time	EN/DIAG=V <sub>DD</sub> , IN2 commutations in PP configuration only. R-L load (120 $\Omega$ , 10 $\mu$ H) to GND for high, low transitions of the output; to V <sub>CC</sub> for low, high transitions			270	ns
		EN/DIAG commutations in HS or LS configurations only. R-L load (120 $\Omega$ , 10 $\mu$ H) to GND in HS; to Vcc in LS			400	ns
t <sub>r(ON)</sub>	OUTx and I/Q rise time (from V <sub>CC</sub> 10% to V <sub>CC</sub> 80%) in push-pull and HS configuration (high-side switch turn-on)	$I_{OUT}=0.2$ A, R-L load (L = 10 $\mu$ H) to GND. I = 0.2 A flowing from the IC to the load. EN/DIAG, IN1 or IN2 commutations	380		860	ns
t <sub>f(ON)</sub>	OUTx and I/Q fall time (from Vcc 90% to Vcc 10%) in push-pull and LS configuration (low-side switch turn-on)	$I_{OUT}=0.2$ A, R-L load (L = 10 $\mu$ H) to V <sub>CC</sub> . I = 0.2 A flowing from the load to the IC. EN/DIAG, IN1 or IN2 commutations	380		860	ns

L6362A Electrical characteristics

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
•	OUTx and I/Q rise time (from Vcc 10% to Vcc 80%)	$I_{OUT} = 0.2$ A, R-L load (L = 10 $\mu$ H) to V <sub>CC</sub> . I = 0.2 A flowing from the load to the OUTL (OUTH floating). EN/DIAG or IN1 commutations	380		860	ns
t <sub>r(OFF)</sub>	in push-pull and LS configuration (low-side switch turn-off)	$I_{OUT}$ = 0.2 A, R-L load (L = 10 $\mu$ H) to V <sub>CC</sub> . I = 0.2 A flowing from the load to the OUT (OUTL=OUTH). IN2 commutations			180	ns
	OUT <sub>X</sub> and I/Q fall time (from V <sub>CC</sub> 90% to V <sub>CC</sub> 10%)	$I_{OUT} = 0.2$ A, R-L load (L = 10 $\mu$ H) to GND. I = 0.2 A flowing from OUTH to the load (OUTL floating). EN/DIAG, or IN1 commutations	380		860	ns
t <sub>f</sub> (OFF)	in push-pull and HS configuration (high-side switch turn-off)	I <sub>OUT</sub> = 0.2 A, R-L load (L = 10 μH) to GND. I = 0.2 A flowing from OUT to the load (OUTH =OUTL). IN2 commutations			180	ns

Table 11: Electrical characteristics, logic inputs (IN1, IN2, EN/DIAG and SEL)

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V <sub>IL</sub>	Input low level voltage (INx, EN/DIAG)				0.3xV <sub>DD</sub>	٧
VIH	Input high level voltage (INx, EN/DIAG)		0.7xV <sub>DD</sub>			٧
V <sub>IHY</sub>	Input level voltage hysteresis (INx, EN/DIAG)		0.08xV <sub>DD</sub>			V
lin	Input current at IN1, IN2, SEL pins	V <sub>IN</sub> = 5 V			2	μA
I <sub>EN</sub>	Input current on EN/DIAG pin	V <sub>EN</sub> = 5 V, internal open drain not active			15	μA
V <sub>EN</sub>	Voltage drop on EN/DIAG pin	I <sub>EN</sub> = 5 mA			0.15	V

Table 12: Protection and diagnostic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
		I <sub>clamp</sub> = 10 mA	38	39	40	
V <sub>clamp</sub>	V <sub>CC</sub> active clamp	I <sub>clamp</sub> = 2 A (peak value during fast transient only)	40	41	42	V
V <sub>demag</sub>	Demagnetization voltage		38	39	40	
I <sub>OLS</sub>	Low-side switch load current limitation level in overload and cut-off		-220		-310	mA



Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
lols-peak	Low-side switch intervention threshold for current limitation and cut-off		-300		-450	mA
Іонѕ	High-side switch load current limitation level in overload and cut-off		220		310	mA
I <sub>OHS</sub> - PEAK	High-side switch intervention threshold for current limitation and cut-off		300		450	mA
tdOUT	Low and high-side cut- off current delay time		3.6		6.4	ms
t <sub>rOUT</sub>	Output stage restart delay time after cut-off or thermal protection intervention		55		105	ms
toL	Overload delay time	OUTH = GND or OUTL = Vcc. Turn on the outputs and measure the delay between limitation event and signalization on OL pin. OL pulled to $V_{DD}$ with R = 3.3 k $\Omega$ , without any capacitor connected versus GND		2.5		μs
VoL	Voltage drop on OL pin	$I_{OL}$ = 1 mA OUTL short to $V_{CC}$ or OUTH short to GND			0.1	V
loL	OL pin leakage current	V <sub>OL</sub> = 5 V internal open drain not active			1	μΑ
I <sub>GD</sub>	Ground rail disconnection output current (HS mode)	OUTH short-circuit to ground rail			500	μA
lvd	Vcc rail disconnection output current (LS mode)	OUTL short-circuit to Vcc rail			500	μA
TJSD	Junction temperature shutdown		150		170	
T <sub>JR</sub>	Junction temperature restart		125		145	°C
Тлнүзт	Junction temperature thermal hysteresis			25		

### Table 13: Linear voltage regulator

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit		
$V_{DD5}$	Regulated output	V <sub>CC</sub> from 7 V to 36 V, no-load on	4.5	5	5.5	V		
V <sub>DD3.3</sub>	voltage	V <sub>DD</sub>	3.0	3.3	3.6	V		
Short-circuit current limitation	SEL = GND	12		20	A			
	limitation	SEL = VDD	10		20	mA		



L6362A Electrical characteristics

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
$\Delta V_{LR}$	Line regulation	$V_{CC} = 8 \text{ to } 36 \text{ V}, T_J = 25 ^{\circ}\text{C},$ Io = 2  mA			8	mV
$\Delta V_{LDR}$	Load regulation	Io = 2 to 7 mA, T <sub>J</sub> = 25 °C	·		20	mV

Output logic L6362A

# 6 Output logic

Table 14: Output stage truth table

Operation	EN/DIAG	IN1	IN2	HS configuration (OUTL not connected)	LS configuration (OUTH not connected)	PP (OUTH wired with OUTL)
Normal	1	0	0	Off (active clamp) <sup>(1)</sup>	On (GND)	GND
Normal	1	0	1	On (Vcc)	Off	Vcc
Normal	1	1	0	On (Vcc)	Off	Vcc
Normal	1	1	1	Off (active clamp)	On (GND)	GND
Normal	0	Х	Х	Off	Off	High Z (slow demagnetization) <sup>(2)</sup>
During DT <sup>(3)</sup>	1	Х	Х			High Z
Cut-off	(4)	Х	Х	Off (active clamp)	Off (active clamp)	High Z
UVLO <sup>(5)</sup>	0	Х	Х	Off (active clamp)	Off (active clamp)	High Z
Overtemperature	0	Х	Х	Off (active clamp)	Off (active clamp)	High Z

#### Notes:

<sup>&</sup>lt;sup>(1)</sup>Active clamp (fast demagnetization) is active in case of residual currents on OUTH or OUTL.

<sup>(2)</sup> See slow demagnetization section.

 $<sup>^{(3)}</sup>$ Dead time is inserted between each HS switch-off and LS switch-on, and vice versa, only if the IC is driven by the IN2 pin. No dead time is inserted when the IN1 pin is commutated.

 $<sup>^{(4)}</sup>$ EN/DIAG pin is driven "high" through a resistor, but the internal open drain is active and the pin is pulled to GND.

 $<sup>^{(5)}\!\</sup>mbox{When VCC}$  < 2.5 V (typ.), the device is completely turned off.

L6362A Receiver logic

# 7 Receiver logic

The level of the signal on I/Q pin is transferred to the  $OUT_{I/Q}$  pin, according to the receiver thresholds defined in and truth table below. The receiver is always active independently on the EN/DIAG pin status. The IN1 pin sets the phase relation between I/Q and  $OUT_{I/Q}$ .

EN/DIAG	IN2	IN1	I/Q	OUT <sub>I/Q</sub>
X	Х	0	0	0
X	Х	0	1	1
X	Х	1	0	1
X	Х	1	1	0
UVLO	Х	Х	Х	0

Х

Χ

IN1 XOR I/Q(1)

Χ

Table 15: I/Q truth table

#### Notes:

Overtemperature

Thanks to the internal pull-up and pull-down resistors on OUTH, OUTL and I/Q pins, the receiver logic can be used for the automatic identification of the load connection (high-side or low-side) even in the 3-wire configurations. Referring to the table above, the microcontroller ( $\mu$ C) can force the EN/DIAG = GND and read the information from OUT I/Q: considering the voltage thresholds VI/QTHLH and VI/QTHHL,  $\mu$ C can know whether the load is connected in high-side or low-side. The table below summarize the OUT I/Q logic level according to the load connection and IN1 set-up.

Table 16: Load connection identification by OUTI/Q

EN/DIA C	INIO	INIA	OU	T <sub>VQ</sub>
EN/DIAG	IN2	IN1	PP-HS	PP-LS
OND	Х	0	0	1
GND	Х	1	1	0

<sup>&</sup>lt;sup>(1)</sup>The receiver keeps working in overtemperature conditions.

## 8 Output stage operation

## 8.1 Set output stage

The IC can be operated in high-side, low-side and push-pull mode, according to the electrical connections on OUTH and OUTL pins. Depending on the chosen operation mode, the IC must be driven by the IN1, IN2 or EN/DIAG pins. Table below refers to normal operation mode. For example, in push-pull mode the driving signal (high = VDD, low = GND) could be applied to IN2 or EN/DIAG only, while IN1 is connected to VDD or GND. In high-side and low-side modes only, the driving signal can be applied to IN1.

Configuration	IN1	IN2		EN/DIAG		OUT	
Push-pull	GND	Drive signal	High	V <sub>DD</sub>		Н	
	V <sub>DD</sub>		Low			L	
			High			L	
			Low			Н	
	Х		Х	GND		High impedance	
	GND	GND				L	
	GND	$V_{DD}$		l	High	Н	
	$V_{DD}$	GND		Drive signal		Н	
	$V_{DD}$	$V_{DD}$				L	
	Х	X			Low	High impedance	

Table 18: Configuration summary 2

Configuration	IN1		IN2		EN/DIAG	OUTL	OUTH
High-side	Drive signal	High	Drive signal or wire to GND or V <sub>DD</sub>	GND	- V <sub>DD</sub> NC	NC	Н
		Low					L
		High		V <sub>DD</sub>			L
		Low					Н
		Х		Х			L
Low-side	Drive signal	High	Drive signal or wire to GND or V <sub>DD</sub>	GND	V <sub>DD</sub>	Н	
		Low				L	NC
		High		V <sub>DD</sub>		L	
		Low				Н	
		Х		Х	GND	Н	

## 8.2 Push-pull (PP) and IO-link operation

The IC can be operated in push-pull mode, with slow demagnetization, by wiring OUTH and OUTL together. When OUTH and OUTL are wired together, IC must be driven by the IN2 pin, to allow the dead time function to properly protect the output stage. IN1 pin sets

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the phase relation between IN2 and the output stage (OUTH, OUTL). The IO-Link operation is active when I/Q pin is connected to OUTH and OUTL by a resistor. According to the required protections and EMC levels, it could be necessary to protect the I/Q pin by an RC net, see the figure below, Section 11.3: "Current limitation and cut-off" and Table 14: "Output stage truth table".

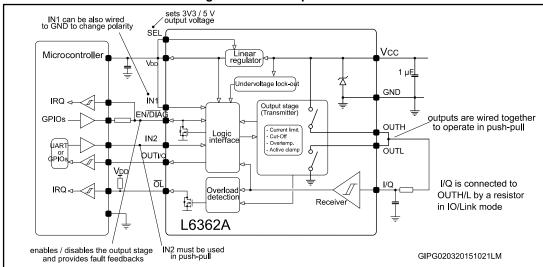


Figure 3: IO-Link operation

## 8.3 High-side operation

The IC can be operated in high-side mode, with active clamping, by leaving the OUTL pin unconnected. IC should be driven by the IN1 pin and IN2 pin sets the phase relation between IN1 and OUTH. See *Table 14: "Output stage truth table"*.

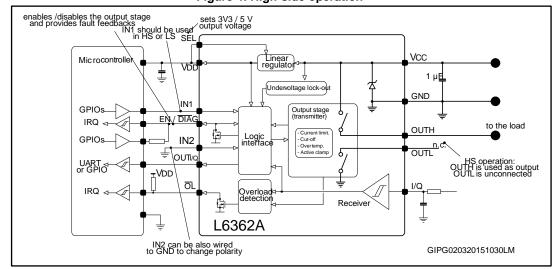


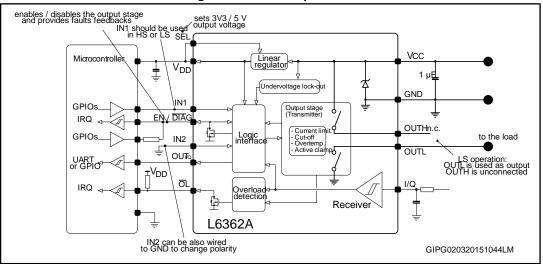
Figure 4: High-side operation

## 8.4 Low-side operation

The IC can be operated in low-side mode, with active clamping, by leaving the OUTH pin unconnected. IC should be driven by the IN1 pin and IN2 pin sets the phase relation between IN1 and OUTL. See *Table 14: "Output stage truth table"*.



Figure 5: Low-side operation



L6362A Active clamp

## 9 Active clamp

Active clamping is always used in HS and LS configurations. In PP configuration slow demagnetization is used. Active clamp is also known as fast demagnetization of inductive loads or fast current decay. When a high-side driver turns off an inductance, a reversed polarity voltage appears across the load. The OUTH pin is pulled to a voltage below the ground until it reaches the demagnetization voltage,  $V_{\text{CC}}$ - $V_{\text{demag}}$ . The conduction state is linearly modulated by an internal circuitry in order to keep the OUTH pin voltage at about  $V_{\text{CC}}$ - $V_{\text{demag}}$  until the energy in the load has been dissipated. The energy is dissipated both in IC internal switch and load resistance. Similarly, in case of load connected between the LS pin and  $V_{\text{CC}}$ , at the switch-off (of the low-side switch) the output is pushed to + $V_{\text{demag}}$ . See *Table 14: "Output stage truth table"* for the detailed behavior of the power stage in different configurations and conditions.

Figure 6: Active clamp equivalent principle schematic. HS configuration (load to GND)

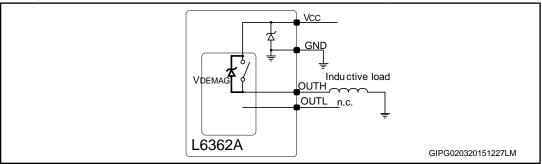
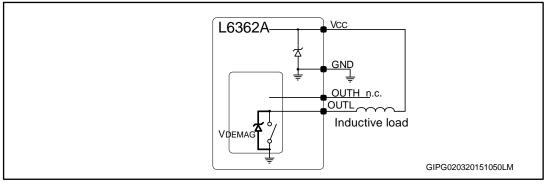
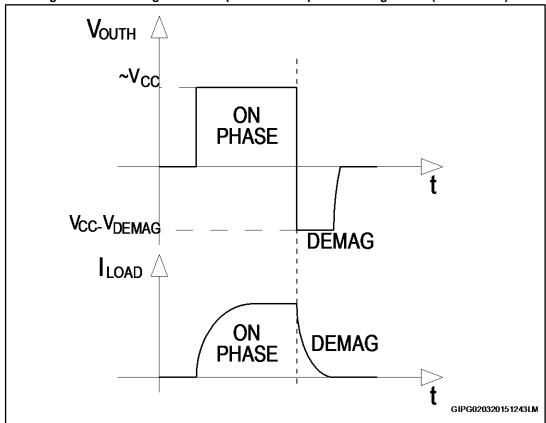


Figure 7: Active clamp equivalent principle schematic. LS configuration (load to VCC)



Active clamp L6362A





L6362A Active clamp

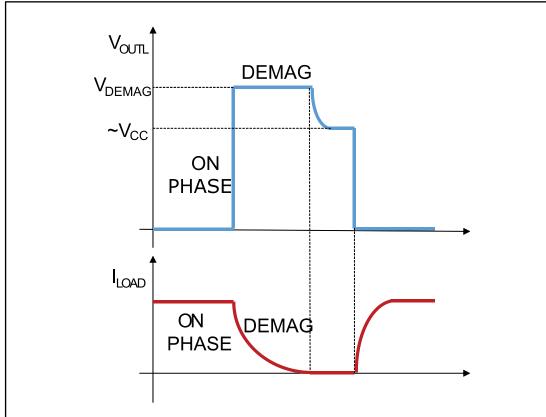


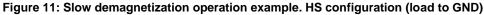
Figure 9: Fast demagnetization operation example. LS configuration (load to VCC)

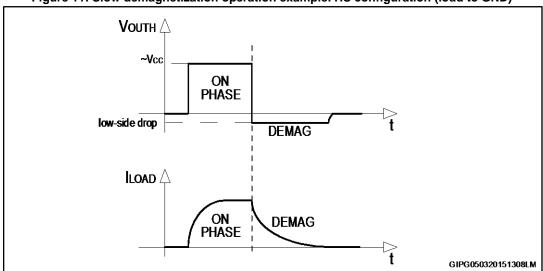
## 10 Slow demagnetization

Slow demagnetization is also known as synchronous rectification or slow current decay and it is active in push pull mode. When a high-side driver turns off an inductance, a reversed polarity voltage appears across the load. In push-pull configuration the low-side switch is ON and the OUTH pin is pulled at a voltage slightly (depending on the low-side switch drop) below the ground. The energy is dissipated in both IC internal switch and load resistance. Similarly, in case of load connected between the OUTL pin and  $V_{\rm CC}$ , at the switch-off of the low-side switch, the HS switch is ON and the output is pushed to a voltage slightly higher than  $V_{\rm CC}$ . Slow demagnetization is always active in PP configurations: the diodes of the integrated switches activate the slow demagnetization even when the IC is driven by EN/DIAG instead of IN2. See *Table 14: "Output stage truth table"* for the detailed behavior of the power stage in different configurations and conditions.

ON phase OUTH Inductive load
OFF phase Slow Demag

Figure 10: Slow demagnetization principle operation. (PP, load to GND)





high side drop

ON
PHASE

ON
PHASE

ON
PHASE

ON
PHASE

Figure 12: Slow demagnetization operation example. LS configuration (load to VCC)

## 11 Protection and diagnostic

The IC integrates several protections to ease the design of a robust application. Protection functions are intended to avoid IC damage in fault conditions and are not intended for continuous operation. Continuous and repetitive operations of protection functions may reduce the IC lifetime.

Table 13. Diagnostic truth table					
Operation	DIAG	OL	HS configuration (OUTL not connected)	LS configuration (OUTH not connected)	PP (OUTH wired to OUTL)
During DT	1	1			High Z slow demagnetization
Cut-off	0	1	Off (active clamp) <sup>(1)</sup>	Off (active clamp)	High Z slow demagnetization
Current limitation	1	0	Linearly controlled	Linearly controlled	Linearly controlled
UVLO <sup>(2)</sup>	0	Not controlled	Off (active clamp)	Off (active clamp)	High Z active clamp
Overtemperature	0	1	Off (active clamp)	Off (active clamp)	High Z slow demagnetization

Table 19: Diagnostic truth table

#### Notes:

## 11.1 Undervoltage lock-out

The output stage, the receiver and several internal circuitries turn off as the supply voltage falls below the turn-off threshold ( $V_{UVOFF}$ ). Normal operation restarts, after  $V_{CC}$  exceeds the turn-on threshold ( $V_{UVON}$ ). Turn-on and turn-off thresholds are defined in table *Table 7:* "Supply".

## 11.2 Overtemperature

The output stage turns off as the internal IC temperature ( $T_J$ ) exceeds the shutdown temperature see *Table 11: "Electrical characteristics, logic inputs (IN1, IN2, EN/DIAG and SEL)"*. Normal operation restarts when the  $T_J$  goes back below the restart temperature ( $T_{jr}$ ) and, in case the cut-off protection is triggered too, after the  $t_{rout}$  delay time expires.

### 11.3 Current limitation and cut-off

The output current of the power stage is internally limited, see *Table 12: "Protection and diagnostic"*.

The current limitation circuit is active when the output current triggers peak threshold (I<sub>OHS-PEAK</sub> for high-side, I<sub>OLS-PEAK</sub> for low-side) by limiting the output current to I<sub>OHS</sub> (or I<sub>OLS</sub> for low-side). The current limitation persists until the current required by the load becomes lower than the limitation level (I<sub>OHS</sub> or I<sub>OLS</sub>).

<sup>&</sup>lt;sup>(1)</sup>Active clamp (fast demagnetization) is active in case of residual currents on OUTH or OUTL. If OUTH and OUTL are wired together, slow demagnetization is used only in case of overtemperature protection intervention.

 $<sup>^{(2)}</sup>$ When Vcc < 2.5 V (typ.), the device is completely turned off.

If the output stage remains in a current limitation condition for a time longer than the  $t_{\text{dOUT}}$  delay, the cut-off occurs, therefore the output stage turns off and restarts after the  $t_{\text{rOUT}}$  restart time. Please notice that the power dissipated by the IC can be significantly high in current limitation condition.

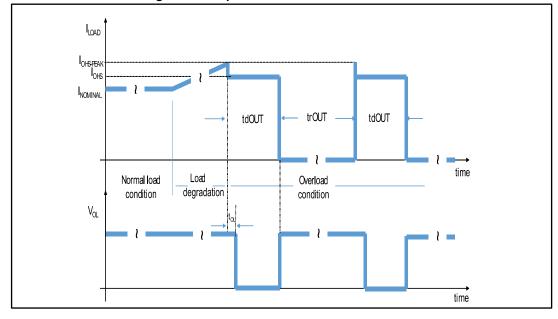


Figure 13: Output current in overload condition

#### 11.4 Dead time

Dead time protection is also known as cross-conduction or shoot-through protection. When used in push-pull configuration, OUTH and OUTL pins are wired together. A dead time is necessary between each high-side switch (HS) turn-off and low-side switch (LS) turn-on, and vice versa, in order to avoid cross-conduction of the two switches. The IC integrates a dead time generator to properly drive the output stage avoiding cross-conduction. The dead time is inserted only when the IN2 pin changes its state. The dead time is not inserted when IN1 or EN/DIAG pin changes its state. The IC must be driven by the IN2 pin in case of push-pull configuration (OUTH and OUTL wired together). The IC should be driven by IN1 in case of HS (OUTL left unconnected) or LS (OUTH left unconnected) configurations, in order to avoid unnecessary delays when the output switch turns on. In any case, the EN/DIAG pin can be also driven by an external source (for example a microcontroller).

### 11.5 EN/DIAG pin

The EN/DIAG pin is internally wired to a diagnostic open drain transistor, so it must be driven by a series resistor only. The open drain transistor is active (turn-on) while any of the following fault conditions is present, independently on the INx pin state:

- Undervoltage lock-out (2.5 V < V<sub>CC</sub> < V<sub>UVOFF</sub>)
- Overtemperature detected (T<sub>J</sub> is above the threshold specified in *Table 12: "Protection and diagnostic"*
- The output turns off due to the cut-off protection

Please note that in case of faults, the output stage (OUTH and OUTL) is disabled by an internal path, independently on the status of the EN/DIAG pin. Besides, note that the diagnostic signal is not visible if the EN/DIAG pin is pulled low from the microcontroller.



## 11.6 OL (overload) pin

The integrated open drain transistor is active (turn-on) in case of overload conditions.

Overload is detected when the output current exceeds the  $I_{OLS-PEAK}$  or  $I_{OHS-PEAK}$  threshold. The open drain transistor is active with a small delay ( $t_{OL}$ ), after the overload condition is detected. Overload is not detected when EN/DIAG pin is at a low logic level. Overload is not detected in cut-off conditions: if the output stage remains in a current limitation (OL) condition for a time longer than the  $t_{dOUT}$  delay, the output stage is turned off (cut-off condition) and the OL pin is released. The output stage is restarted after the  $t_{rOUT}$  restart time

### 11.7 Reverse polarity protection

The integrated reverse polarity protection (RPP) avoids any damage to the IC in case of erroneous swapped connection of the high voltage pins to the supply and reference rails. These protected pins, despite reverse polarity, are: VCC, GND, OUTH, OUTL and I/Q. In order to protect the IC against any reverse current from load (e.g due to different and unbalanced supply load voltage rails), please refer to section below.

## 11.8 GND/VCC open wire protection

The GND and  $V_{\text{CC}}$  open wire protections are intended as protections against the disconnection of the application module from ground and/or supply rails. The IC is self-protected against these events both for high-side and low-side configurations.

For Push-Pull configuration an external blocking diode in series to OUTH is necessary if load is connected to  $V_{CC}$  supply rail. An external diode in series to OUTL is necessary if the load is connected to GND reference rail.

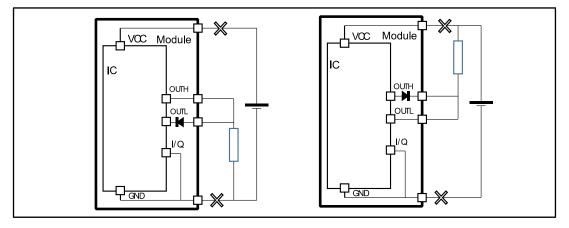


Figure 14: PP configuration, open wire external protections

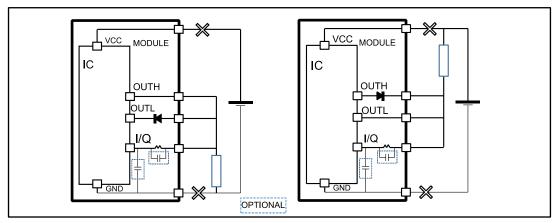
The same considerations for PP configuration are valid for IO-Link configuration. Furthermore, the external resistor between I/Q and load has to be selected to force the IC in UVLO off. A 22 kOhm resistor protects the IC up to  $V_{\rm CC}$  = 36 V, even though a lower value resistance can be used according to the following design rule:

 $R_{ext} = [V_{CC(max.)} - V_{uvoff(min.)}]/I_{CC}(min.)$ 

Despite the presence of the external components listed above, the IC is able to meet the standard EMC requirements according to IEC 60947-5-2. Only if higher voltage levels are necessary, then a small C<sub>I/Q</sub> capacitance between I/Q and GND could be necessary: the

effects at high switching frequency of  $R_{\text{ext}}$  and  $C_{\text{I/Q}}$  can be limited by a further small capacitance in parallel to  $R_{\text{ext}}$ .

Figure 15: IO-Link configuration, open wire external protections





Typical application L6362A

# 12 Typical application

Figure 16: Typical IO-Link sensor application 2

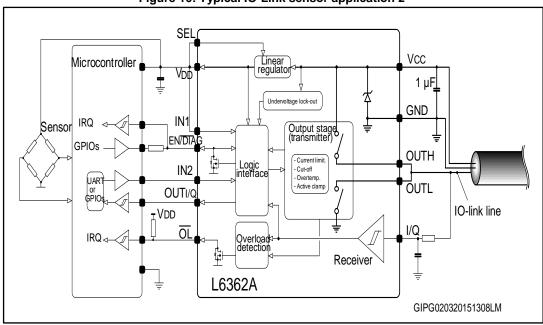
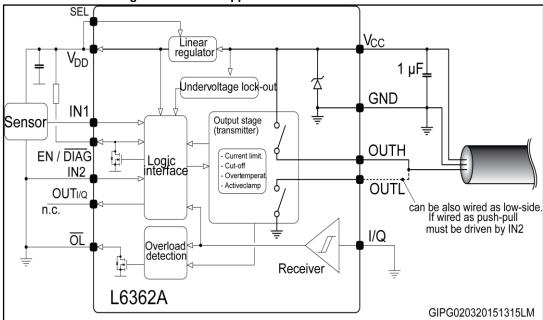


Figure 17: Sensor application without microcontroller



L6362A Typical application

Figure 18: Inductive load driver SEL Microcontroller Vcc Linear regulator  $V_{DD}$  $1 \mu F$ \$ Undervoltage lock-out **GND** Can be configured as HS (load to GND) or LS (load to Vcc) IN1 Output stage (Transmitter) **GPIOs** EN / DIAG OUTH Inductive load - Current limit. - Cut-off Logic interface IN2 - Overtemp. - Active clamp OUTL 7 6, <sup>‡</sup>OUTι/α Inductive load T  $_{\mathtt{T}}\mathsf{V}_{\mathtt{DD}}$ |/Q |-|-|-|-|-ŌĹ Overload detection ŧ Receiver بإي L6362A GIPG020320151324LM

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# 13 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: **www.st.com**. ECOPACK® is an ST trademark.

## 13.1 VFDFPN 12L (3x3x0.90 mm) package information

Figure 19: VFDFPN 12L (3x3x0.90 mm) package outline

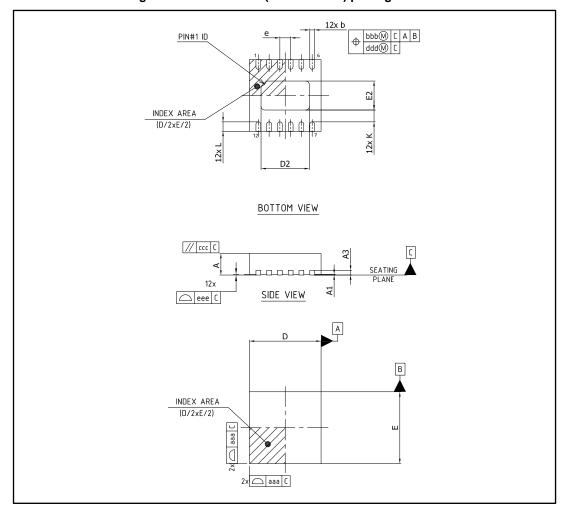


Table 20: VFDFPN 12L (3x3x0.90 mm) package mechanical data

Dim.	mm					
Dilli.	Min.	Тур.	Max.			
А	0.80	0.90	1.00			
A1	0.00	0.02	0.05			
A3		0.20 BSC				
b	0.15		0.30			
D		3.00 BSC				
Е		3.00 BSC				
D2	1.87	2.02	2.12			
E2	1.06	1.21	1.31			
е		0.45 BSC				
L	0.30	0.40	0.50			
k	0.20					
aaa		0.05				
bbb		0.10				
ccc		0.10				
ddd		0.05				
eee		0.08				



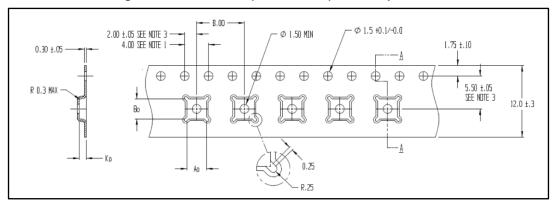
VFDFPN stands for thermally enhanced plastic: very thin, fine pitch, dual flat package and no lead. The lead size is comprehensive of the thickness of the lead finishing material. Dimensions do not include mold protrusion, not to exceed 0.15 mm. Package outline exclusive of metal burr dimensions. Pits, visible to the naked eye, are not allowed on the marking area.

2,55 2,15 2,15 NIM SEE 0 0,45

Figure 20: VFDFPN 12L (3x3x0.90 mm) recommended footprint

# 13.2 VFDFPN 12L (3x3x0.90 mm) packing information

Figure 21: VFDFPN 12L (3x3x0.90 mm) carrier tape outline



L6362A Package information

#0.5 0.2 #1.3 #0.3 #0.3 #0.3 (Measured at hub)

2.2

Figure 22: VFDFPN 12L (3x3x0.90 mm) reel outline

+2 0

(Measured at hub) 12.4

Revision history L6362A

# 14 Revision history

Table 21: Document revision history

Date	Revision	Changes		
20-Mar-2015	1	Initial release.		
04-May-2015	2	Updated features.  Updated section 2.3.  Updated min. and max. value of I <sub>OLS-PEAK</sub> parameter in table 3.  Added V <sub>EN</sub> parameter to table 11.  Added V <sub>OL</sub> and I <sub>OL</sub> parameter to table 12.  Updated EN/DIAG value in table 14 and DIAG value in table 17.		
29-Jan-2016	3	Updated section"Features", section "Description", table 2: "Pin description", all tables related to section 5: "Electrical characteristics", section 6: "Output logic", section 9: "Active clamp", section 10: "Slow demagnetization", section 11: "Protection and diagnostic".		
03-Feb-2016	4	Document status promoted from preliminary to production data.		
16-Mar-2016	5	Updated the device summary table.		
01-Apr-2016	6	Updated VFDFPN 12L (3x3x0.90 mm) package information.		
28-Apr-2016	7	Updated table titled "Output stage".  Updated "Current limitation and cut-off" section.  Changed figure titled "Output current in overload condition".		
13-Jun-2016	8	Added VFDFPN 12L (3x3x0.90 mm) packing information.		
20-Jul-2016	9	Updated OUTI/Q		
22-Nov-2017	10	Updated the description and the device summary table.  Updated Figure 1: "Block diagram".  Updated Section 2.7: "OL".  Updated Section 3: "Absolute maximum ratings".  Updated Table 7: "Supply", Table 9: "I/Q receiver" and Table 18: "Configuration summary 2".  Updated Section 8.1: "Set output stage".  Updated Figure 3: "IO-Link operation", Figure 9: "Fast demagnetization operation example. LS configuration (load to VCC)", Figure 14: "PP configuration, open wire external protections" and Figure 15: "IO-Link configuration, open wire external protections".  Added Section 11.8: "GND/VCC open wire protection".		

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